

Search Notes

Application/Control No.

10/778,029

Examiner

Ginette Peralta

Applicant(s)/Patent under
Reexamination

ISHIYAMA

Art Unit

2814

SEARCHED

Class	Subclass	Date	Examiner
257	683	6/9/2005	GP
257	687	6/9/2005	GP
257	706	6/9/2005	GP
257	717	6/9/2005	GP
257	719	6/9/2005	GP
257	723	6/9/2005	GP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
(chip or die or dice) and ((inner or interior or internal) adj2 pressure) and ((resin or epoxy) with mold)	6/9/2005	GP
(chip or die or dice) and (inner or internal or interior) with pressure and (resin or epoxy) and module and electrode	6/9/2005	GP